Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/706,050	LEE ET AL.	
Examiner	Art Unit	
HOAN C. NGUYEN	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	61	7/26/2005	СНИ	
345	84	7/26/2005	CHN	
-				
······································				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	 			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
east search	7/26/2005	СНИ	
· · · · · · · · · · · · · · · · · · ·			
-	·		